

Notice of References Cited	Application/Control No. 10/074,484	Applicant(s)/Patent Under Reexamination ANDERSEN ET AL.	
	Examiner Son P. Huynh	Art Unit 2623	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,172,677	01-2001	Stautner et al.	715/716
*	B	US-6,268,849	07-2001	Boyer et al.	725/40
*	C	US-6,469,753	10-2002	Klosterman et al.	348/552
*	D	US-6,487,722	11-2002	Okura et al.	725/40
*	E	US-5,801,747	09-1998	Bedard, Karen	725/46
*	F	US-6,008,803	12-1999	Rowe et al.	715/721
*	G	US-6,675,385	01-2004	Wang, Jeffrey Yutong	725/39
*	H	US-6,505,348	01-2003	Knowles et al.	725/49
*	I	US-6,973,621	12-2005	Sie et al.	715/720
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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